Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/775,866	YOSHIDA ET AL.	
Examiner	Art Unit	
RICARDO L. OSORIO	2629	

RICARDO L. OSORIO

SEARCHED						
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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